

# IMPORTANT NOTICE

10 December 2015

## 1. Global joint venture starts operations as WeEn Semiconductors

Dear customer,

As from November 9th, 2015 NXP Semiconductors N.V. and Beijing JianGuang Asset Management Co. Ltd established Bipolar Power joint venture (JV), **WeEn Semiconductors**, which will be used in future Bipolar Power documents together with new contact details.

In this document where the previous NXP references remain, please use the new links as shown below.

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Thank you for your cooperation and understanding,

WeEn Semiconductors



# BT151X-650C

## SCR

16 March 2014

Product data sheet

## 1. General description

Planar passivated Silicon Controlled Rectifier (SCR) in a SOT186A (TO-220F) "full pack" plastic package intended for use in applications requiring high bidirectional blocking voltage capability and high thermal cycling performance.

## 2. Features and benefits

- High bidirectional blocking voltage capability
- High thermal cycling performance
- Isolated mounting base package
- Planar passivated for voltage ruggedness and reliability

## 3. Applications

- Capacitive Discharge Ignition (CDI)
- Crowbar protection
- Inrush protection
- Motor control
- Voltage regulation

## 4. Quick reference data

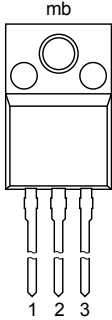
Table 1. Quick reference data

| Symbol                        | Parameter                            | Conditions                                                                                                            | Min | Typ | Max | Unit |
|-------------------------------|--------------------------------------|-----------------------------------------------------------------------------------------------------------------------|-----|-----|-----|------|
| $V_{DRM}$                     | repetitive peak off-state voltage    |                                                                                                                       | -   | -   | 650 | V    |
| $V_{RRM}$                     | repetitive peak reverse voltage      |                                                                                                                       | -   | -   | 650 | V    |
| $I_{TSM}$                     | non-repetitive peak on-state current | half sine wave; $T_{j(init)} = 25\text{ °C}$ ; $t_p = 10\text{ ms}$ ; <a href="#">Fig. 4</a> ; <a href="#">Fig. 5</a> | -   | -   | 100 | A    |
| $I_{T(RMS)}$                  | RMS on-state current                 | half sine wave; $T_h \leq 69\text{ °C}$ ; <a href="#">Fig. 1</a> ; <a href="#">Fig. 2</a> ; <a href="#">Fig. 3</a>    | -   | -   | 12  | A    |
| <b>Static characteristics</b> |                                      |                                                                                                                       |     |     |     |      |
| $I_{GT}$                      | gate trigger current                 | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; $T_j = 25\text{ °C}$ ; <a href="#">Fig. 7</a>                            | -   | 2   | 15  | mA   |



## 5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description             | Simplified outline                                                                                         | Graphic symbol                                                                      |
|-----|--------|-------------------------|------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------|
| 1   | K      | cathode                 |  <p>TO-220F (SOT186A)</p> |  |
| 2   | A      | anode                   |                                                                                                            |                                                                                     |
| 3   | G      | gate                    |                                                                                                            |                                                                                     |
| mb  | n.c.   | mounting base; isolated |                                                                                                            |                                                                                     |

## 6. Ordering information

Table 3. Ordering information

| Type number | Package |                                                                                                     |         |
|-------------|---------|-----------------------------------------------------------------------------------------------------|---------|
|             | Name    | Description                                                                                         | Version |
| BT151X-650C | TO-220F | plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3-lead TO-220 "full pack" | SOT186A |

## 7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol              | Parameter                            | Conditions                                                                                                                       | Min | Max | Unit                   |
|---------------------|--------------------------------------|----------------------------------------------------------------------------------------------------------------------------------|-----|-----|------------------------|
| $V_{\text{DRM}}$    | repetitive peak off-state voltage    |                                                                                                                                  | -   | 650 | V                      |
| $V_{\text{RRM}}$    | repetitive peak reverse voltage      |                                                                                                                                  | -   | 650 | V                      |
| $I_{\text{T(AV)}}$  | average on-state current             | half sine wave; $T_h \leq 69^\circ\text{C}$                                                                                      | -   | 7.5 | A                      |
| $I_{\text{T(RMS)}}$ | RMS on-state current                 | half sine wave; $T_h \leq 69^\circ\text{C}$ ; <a href="#">Fig. 1</a> ; <a href="#">Fig. 2</a> ; <a href="#">Fig. 3</a>           | -   | 12  | A                      |
| $I_{\text{TSM}}$    | non-repetitive peak on-state current | half sine wave; $T_{j(\text{init})} = 25^\circ\text{C}$ ; $t_p = 10\text{ ms}$ ; <a href="#">Fig. 4</a> ; <a href="#">Fig. 5</a> | -   | 100 | A                      |
|                     |                                      | half sine wave; $T_{j(\text{init})} = 25^\circ\text{C}$ ; $t_p = 8.3\text{ ms}$                                                  | -   | 110 | A                      |
| $I^2t$              | $I^2t$ for fusing                    | $t_p = 10\text{ ms}$ ; SIN                                                                                                       | -   | 50  | $\text{A}^2\text{s}$   |
| $di_{\text{T}}/dt$  | rate of rise of on-state current     | $I_{\text{T}} = 20\text{ A}$ ; $I_{\text{G}} = 50\text{ mA}$ ; $di_{\text{G}}/dt = 50\text{ mA}/\mu\text{s}$                     | -   | 50  | $\text{A}/\mu\text{s}$ |
| $I_{\text{GM}}$     | peak gate current                    |                                                                                                                                  | -   | 2   | A                      |

| Symbol      | Parameter                 | Conditions            |  | Min | Max | Unit |
|-------------|---------------------------|-----------------------|--|-----|-----|------|
| $V_{RGM}$   | peak reverse gate voltage |                       |  | -   | 5   | V    |
| $P_{GM}$    | peak gate power           |                       |  | -   | 5   | W    |
| $P_{G(AV)}$ | average gate power        | over any 20 ms period |  | -   | 0.5 | W    |
| $T_{stg}$   | storage temperature       |                       |  | -40 | 150 | °C   |
| $T_j$       | junction temperature      |                       |  | -   | 125 | °C   |

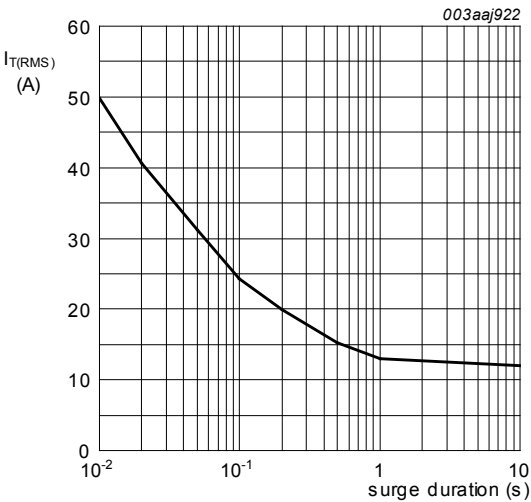


Fig. 1. RMS on-state current as a function of surge duration; maximum values

$f = 50\text{ Hz}; T_h = 69\text{ °C}$

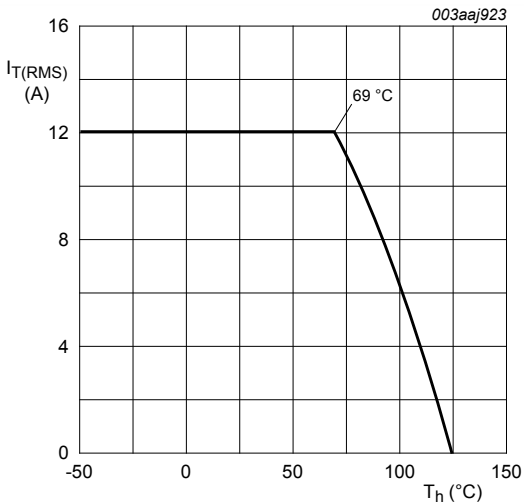


Fig. 2. RMS on-state current as a function of heatsink temperature; maximum values

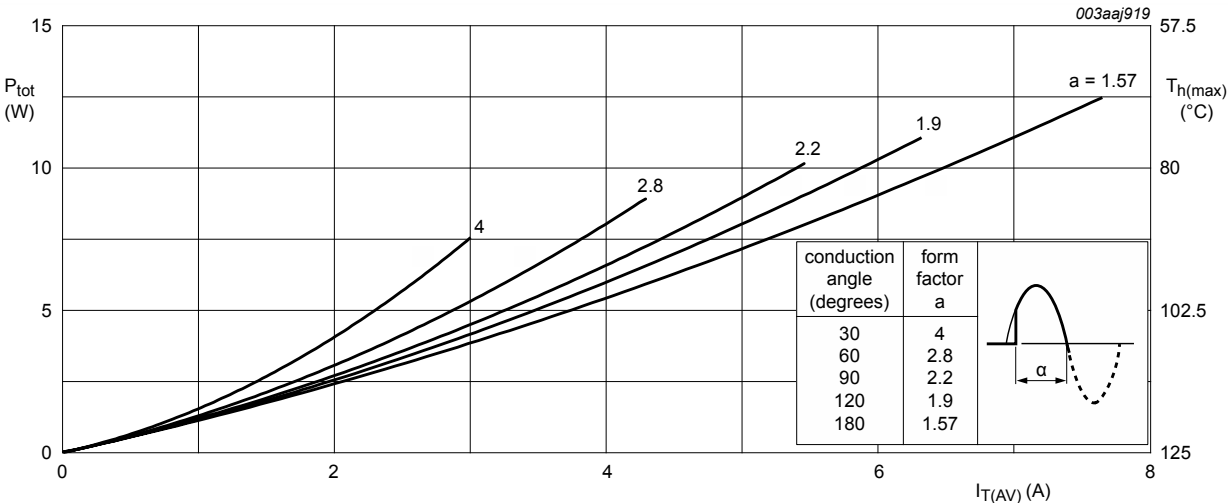
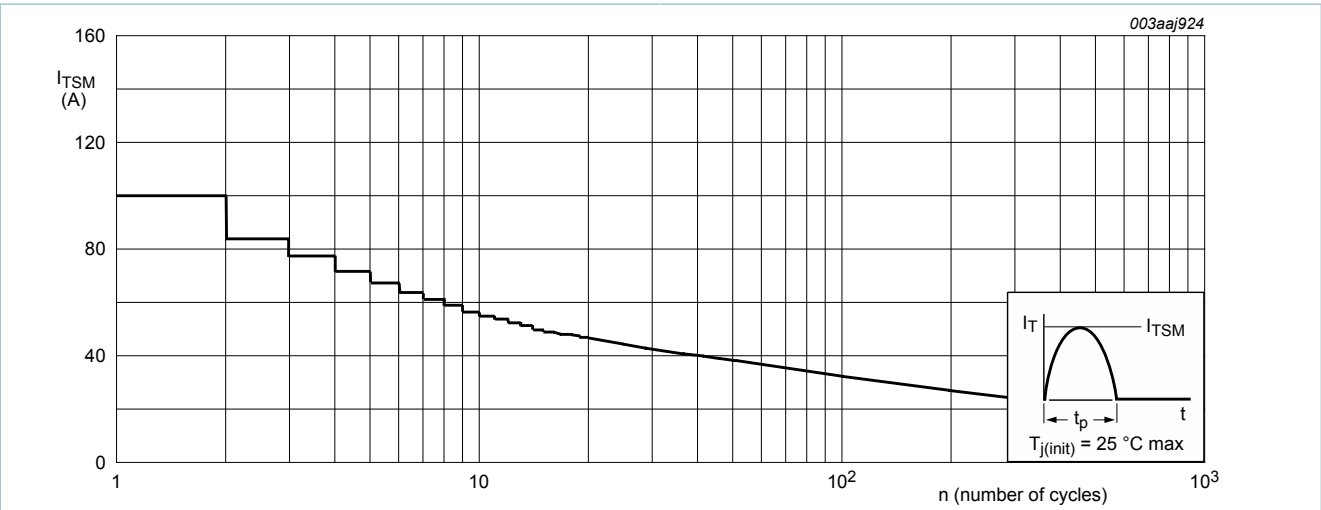
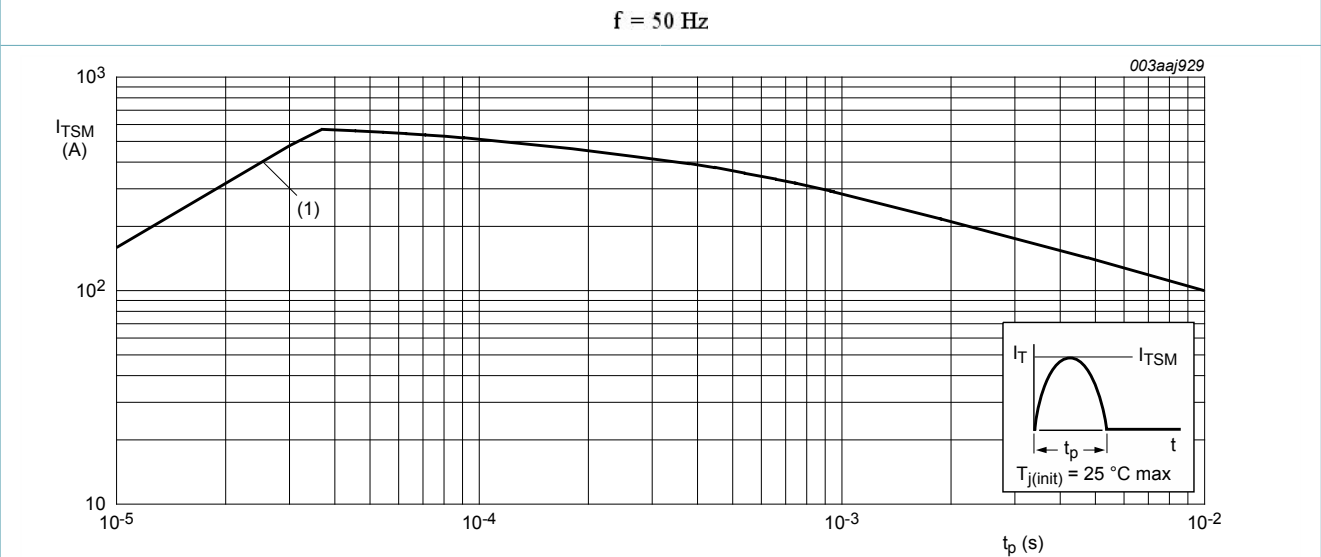


Fig. 3. Total power dissipation as a function of average on-state current; maximum values

$\alpha = \text{conduction angle}$      $a = \text{form factor} = I_{T(RMS)} / I_{T(AV)}$



**Fig. 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values**



**Fig. 5. Non-repetitive peak on-state current as a function of pulse width; maximum values**

$$t_p \leq 10\text{ ms; (1) } dI_T/dt \text{ limit}$$

## 8. Thermal characteristics

**Table 5. Thermal characteristics**

| Symbol        | Parameter                                    | Conditions                                        | Min | Typ | Max | Unit |
|---------------|----------------------------------------------|---------------------------------------------------|-----|-----|-----|------|
| $R_{th(j-h)}$ | thermal resistance from junction to heatsink | with heatsink compound; <a href="#">Fig. 6</a>    | -   | -   | 4.5 | K/W  |
|               |                                              | without heatsink compound; <a href="#">Fig. 6</a> | -   | -   | 6.5 | K/W  |
| $R_{th(j-a)}$ | thermal resistance from junction to ambient  | in free air                                       | -   | 55  | -   | K/W  |

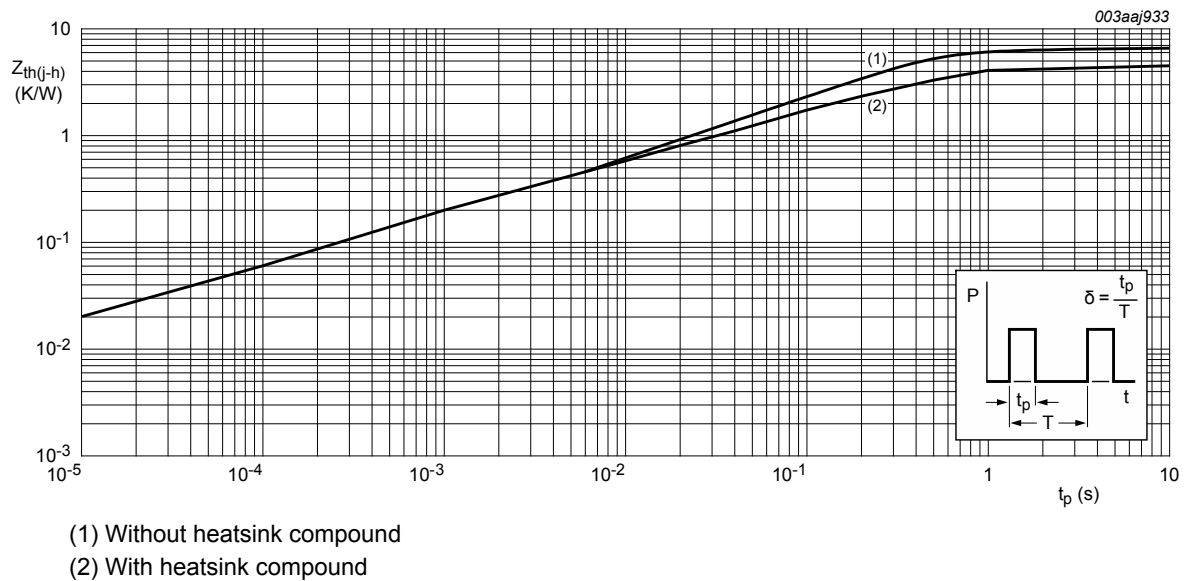


Fig. 6. Transient thermal impedance from junction to heatsink as a function of pulse width

## 9. Isolation characteristics

Table 6. Isolation characteristics

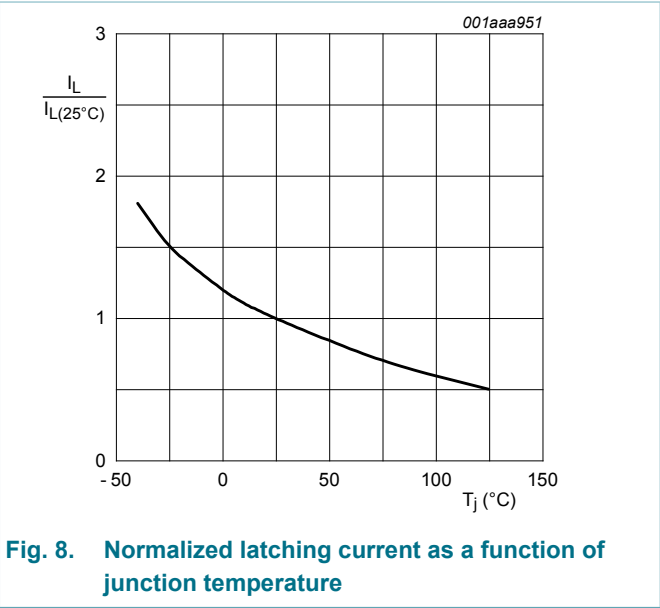
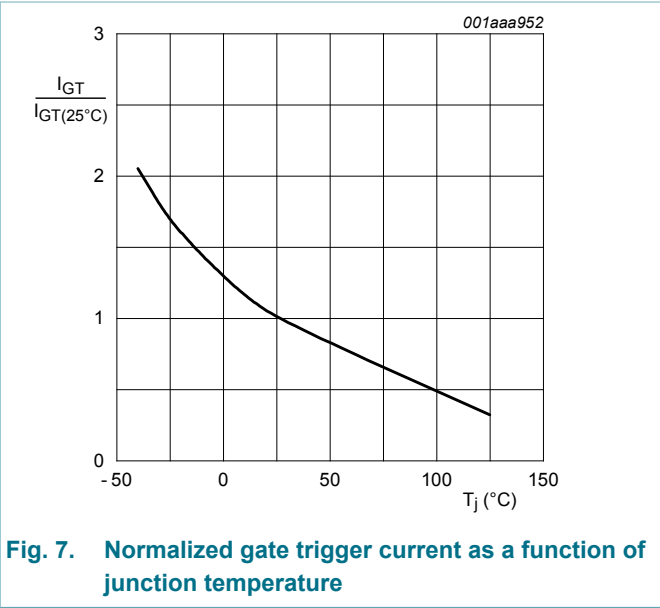
| Symbol          | Parameter             | Conditions                                                                                                                                                                              | Min | Typ | Max  | Unit |
|-----------------|-----------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|-----|------|------|
| $V_{isol(RMS)}$ | RMS isolation voltage | from all terminals to external heatsink;<br>sinusoidal waveform; clean and dust<br>free; $50\text{ Hz} \leq f \leq 60\text{ Hz}$ ; $RH \leq 65\%$ ;<br>$T_h = 25\text{ }^\circ\text{C}$ | -   | -   | 2500 | V    |
| $C_{isol}$      | isolation capacitance | from anode to external heatsink;<br>$f = 1\text{ MHz}$ ; $T_h = 25\text{ }^\circ\text{C}$                                                                                               | -   | 10  | -    | pF   |

## 10. Characteristics

Table 7. Characteristics

| Symbol                        | Parameter            | Conditions                                                                                                   | Min  | Typ | Max  | Unit |
|-------------------------------|----------------------|--------------------------------------------------------------------------------------------------------------|------|-----|------|------|
| <b>Static characteristics</b> |                      |                                                                                                              |      |     |      |      |
| $I_{GT}$                      | gate trigger current | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; $T_j = 25\text{ }^\circ\text{C}$ ; <a href="#">Fig. 7</a>       | -    | 2   | 15   | mA   |
| $I_L$                         | latching current     | $V_D = 12\text{ V}$ ; $I_G = 0.1\text{ A}$ ; $T_j = 25\text{ }^\circ\text{C}$ ; <a href="#">Fig. 8</a>       | -    | 10  | 40   | mA   |
| $I_H$                         | holding current      | $V_D = 12\text{ V}$ ; $T_j = 25\text{ }^\circ\text{C}$ ; <a href="#">Fig. 9</a>                              | -    | 7   | 20   | mA   |
| $V_T$                         | on-state voltage     | $I_T = 23\text{ A}$ ; $T_j = 25\text{ }^\circ\text{C}$ ; <a href="#">Fig. 10</a>                             | -    | 1.4 | 1.75 | V    |
| $V_{GT}$                      | gate trigger voltage | $V_D = 12\text{ V}$ ; $I_T = 0.1\text{ A}$ ; $T_j = 25\text{ }^\circ\text{C}$ ;<br><a href="#">Fig. 11</a>   | -    | 0.6 | 1    | V    |
|                               |                      | $V_D = 650\text{ V}$ ; $I_T = 0.1\text{ A}$ ; $T_j = 125\text{ }^\circ\text{C}$ ;<br><a href="#">Fig. 11</a> | 0.25 | 0.4 | -    | V    |

| Symbol                  | Parameter                         | Conditions                                                                                                                                                                                                                                      |  | Min | Typ  | Max | Unit       |
|-------------------------|-----------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--|-----|------|-----|------------|
| $I_D$                   | off-state current                 | $V_D = 650\text{ V}; T_j = 125\text{ }^\circ\text{C}$                                                                                                                                                                                           |  | -   | 0.1  | 0.5 | mA         |
| $I_R$                   | reverse current                   | $V_R = 650\text{ V}; T_j = 125\text{ }^\circ\text{C}$                                                                                                                                                                                           |  | -   | 0.1  | 0.5 | mA         |
| Dynamic characteristics |                                   |                                                                                                                                                                                                                                                 |  |     |      |     |            |
| $dV_D/dt$               | rate of rise of off-state voltage | $V_{DM} = 436\text{ V}; T_j = 125\text{ }^\circ\text{C}; R_{GK} = 100\text{ }\Omega;$<br>( $V_{DM} = 67\%$ of $V_{DRM}$ ); exponential waveform; <a href="#">Fig. 12</a>                                                                        |  | 200 | 1000 | -   | V/ $\mu$ s |
|                         |                                   | $V_{DM} = 436\text{ V}; T_j = 125\text{ }^\circ\text{C};$ ( $V_{DM} = 67\%$ of $V_{DRM}$ ); exponential waveform; gate open circuit; <a href="#">Fig. 12</a>                                                                                    |  | 50  | 130  | -   | V/ $\mu$ s |
| $t_{gt}$                | gate-controlled turn-on time      | $I_{TM} = 40\text{ A}; V_D = 650\text{ V}; I_G = 100\text{ mA};$<br>$dI_G/dt = 5\text{ A}/\mu\text{s}; T_j = 25\text{ }^\circ\text{C}$                                                                                                          |  | -   | 2    | -   | $\mu$ s    |
| $t_q$                   | commutated turn-off time          | $V_{DM} = 436\text{ V}; T_j = 125\text{ }^\circ\text{C}; I_{TM} = 20\text{ A};$<br>$V_R = 25\text{ V}; (dI_T/dt)_M = 30\text{ A}/\mu\text{s}; dV_D/dt = 50\text{ V}/\mu\text{s};$<br>$R_{GK} = 100\text{ }\Omega; (V_{DM} = 67\%$ of $V_{DRM})$ |  | -   | 70   | -   | $\mu$ s    |



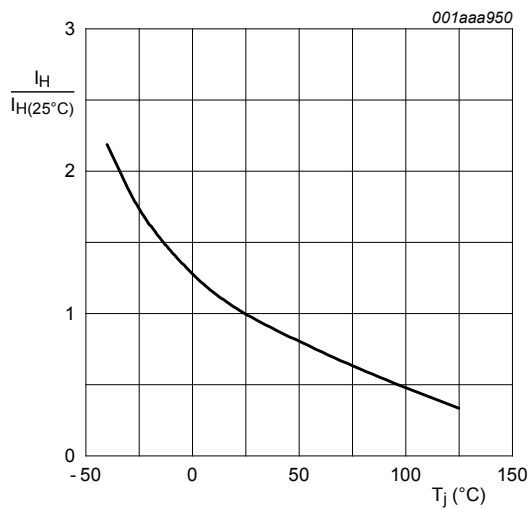
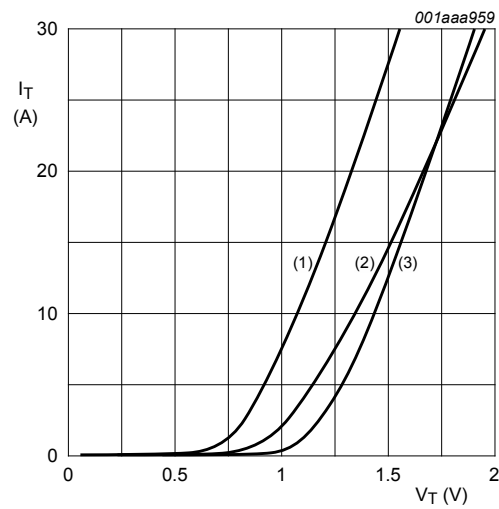


Fig. 9. Normalized holding current as a function of junction temperature



$V_o = 1.06\text{ V}; R_s = 0.0304\ \Omega$   
(1)  $T_j = 125\text{ }^\circ\text{C}$ ; typical values  
(2)  $T_j = 125\text{ }^\circ\text{C}$ ; maximum values  
(3)  $T_j = 25\text{ }^\circ\text{C}$ ; maximum values

Fig. 10. On-state current as a function of on-state voltage

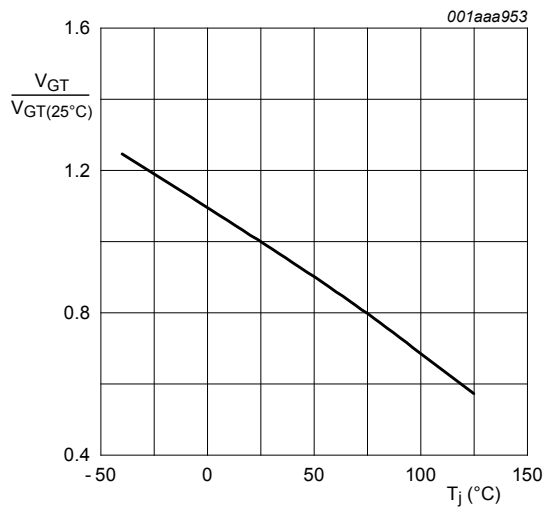
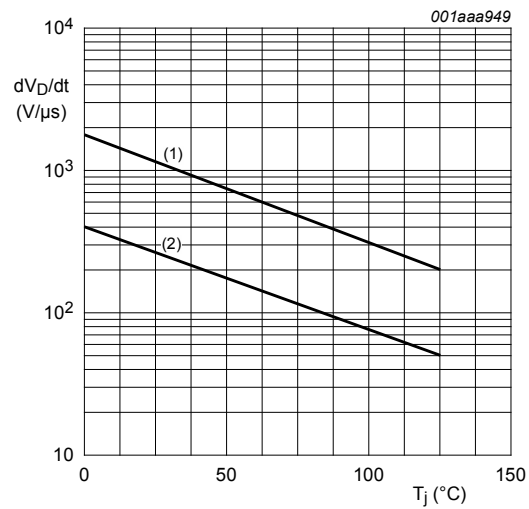


Fig. 11. Normalized gate trigger voltage as a function of junction temperature



(1)  $R_{GK} = 100\ \Omega$ ;  
(2) gate open circuit

Fig. 12. Critical rate of rise of off-state voltage as a function of junction temperature; minimum values



11. Package outline

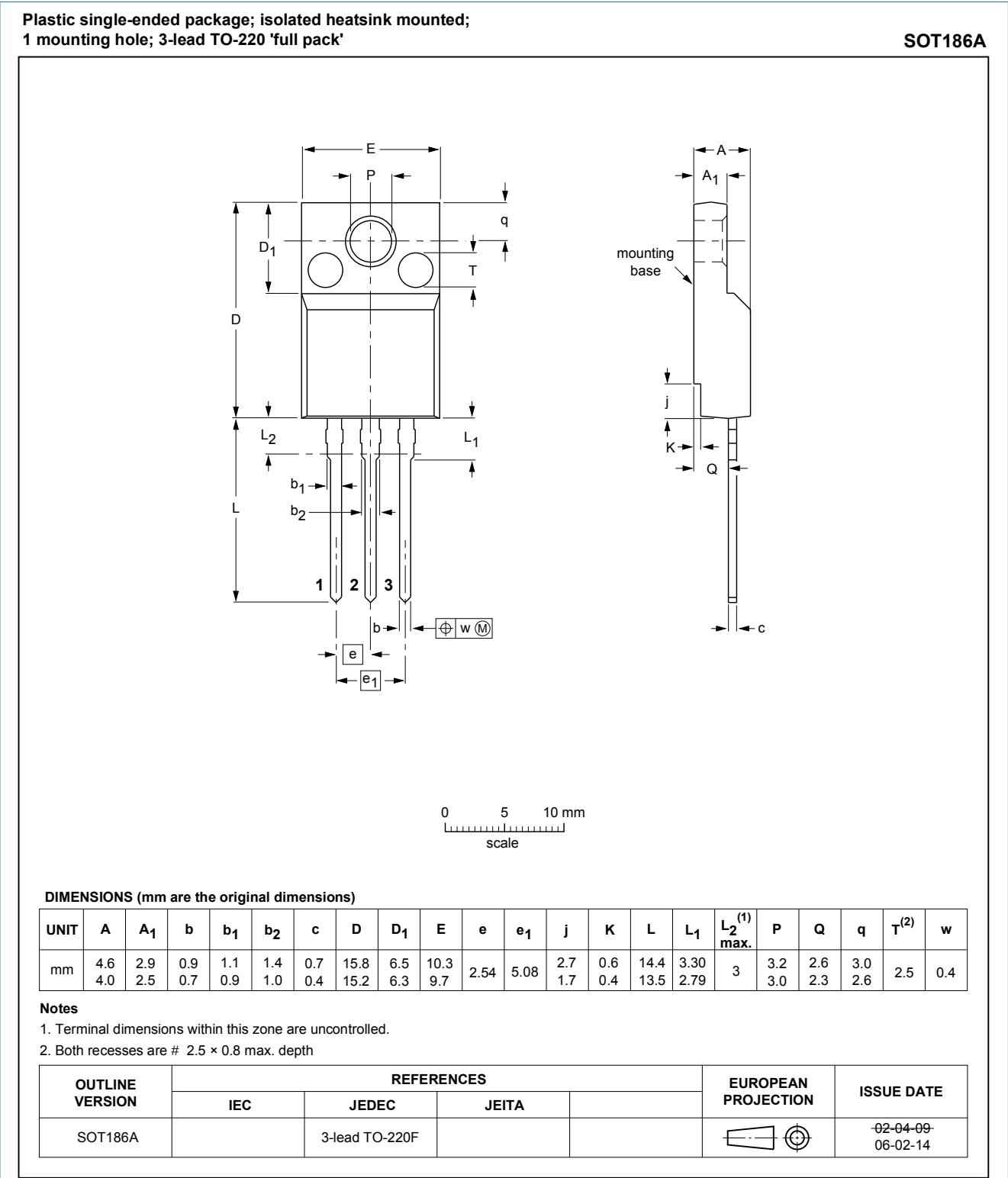


Fig. 13. Package outline TO-220F (SOT186A)

## 12. Legal information

### 12.1 Data sheet status

| Document status [1][2]         | Product status [3] | Definition                                                                            |
|--------------------------------|--------------------|---------------------------------------------------------------------------------------|
| Objective [short] data sheet   | Development        | This document contains data from the objective specification for product development. |
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| Product [short] data sheet     | Production         | This document contains the product specification.                                     |

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